## N-channel 100V-0.030 - 25A - DPAK <br> Low gate charge STripFET ${ }^{\text {TM }}$ II Power MOSFET

## General features

| Type | $\mathbf{V}_{\text {DSS }}$ | $\mathbf{R}_{\text {DS(on) }}$ | $\mathbf{I}_{\mathbf{D}}$ |
| :---: | :---: | :---: | :---: |
| STD25NF10L | 100 V | $<0.035 \Omega$ | 25 A |

- Exceptional dv/dt capability
- $100 \%$ avalanche tested

■ Low threshold device

- Logic level device


## Description

This Power MOSFET series realized with STMicroelectronics unique STripFET process has specifically been designed to minimize input capacitance and gate charge. It is therefore suitable as primary switch in advanced highefficiency isolated DC-DC converters for Telecom and Computer application. It is also intended for any application with low gate charge drive requirements.

## Applications

■ Switching application


DPAK

Internal schematic diagram


## Order codes

| Part number | Marking | Package | Packaging |
| :---: | :---: | :---: | :---: |
| STD25NF10LT4 | D25NF10L | DPAK | Tape \& reel |

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## 1

Electrical ratings

Table 1. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{V}_{\mathrm{DS}}$ | Drain-source voltage $\left(\mathrm{V}_{\mathrm{GS}}=0\right)$ | 100 | V |
| $\mathrm{~V}_{\mathrm{DGR}}$ | Drain-gate voltage $\left(\mathrm{R}_{\mathrm{GS}}=20 \mathrm{kS}\right)$ | 100 | V |
| $\mathrm{~V}_{\mathrm{GS}}$ | Gate- source voltage | $\pm 16$ | V |
| $\mathrm{I}_{\mathrm{D}}{ }^{(1)}$ | Drain current (continuous) at $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | 25 | A |
| $\mathrm{I}_{\mathrm{D}}$ | Drain current (continuous) at $\mathrm{T}_{\mathrm{C}}=100^{\circ} \mathrm{C}$ | 21 | A |
| $\mathrm{I}_{\mathrm{DM}}{ }^{(2)}$ | Drain current (pulsed) | 100 | A |
| $\mathrm{P}_{\mathrm{tot}}$ | Total dissipation at $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | 100 | W |
|  | Derating Factor | 0.67 | $\mathrm{~W} /{ }^{\circ} \mathrm{C}$ |
| $\mathrm{dv} / \mathrm{dt}^{(3)}$ | Peak diode recovery avalanche energy | 20 | $\mathrm{~V} / \mathrm{ns}$ |
| $\mathrm{E}_{\mathrm{AS}}{ }^{(4)}$ | Single pulse avalanche energy | 450 | mJ |
| $\mathrm{~T}_{\text {stg }}$ | Storage temperature | -55 to 175 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{j}}$ | Max. operating junction temperature |  |  |

1. Current limited by package
2. Pulse width limited by safe operating area.
3. $I_{S D} \leq 25 A, d i / d t \leq 300 A / \mu s, V_{D D}=V(B R) D S S, T_{j} \leq T_{J M A X}$
4. Starting $\mathrm{T}_{\mathrm{j}}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{D}}=12.5 \mathrm{~A} \mathrm{~V}_{\mathrm{DD}}=50 \mathrm{~V}$

Table 2. Thermal data

| Rthj-case | Thermal resistance junction-case max | 1.5 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| :---: | :--- | :---: | :---: |
| Rthj-pcb | Thermal resistance junction-pcb max ${ }^{(1)}$ | 100 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{T}_{J}$ | Maximum lead temperature for soldering purpose | 275 | ${ }^{\circ} \mathrm{C}$ |

1. When Mounted on 1 inch2 FR-4 board, 2 oz of Cu .

## 2 Electrical characteristics

( $\mathrm{T}_{\text {CASE }}=25^{\circ} \mathrm{C}$ unless otherwise specified)

Table 3. On/off states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{(\mathrm{BR}) \mathrm{DSS}}$ | Drain-source <br> breakdown voltage | $\mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0$ | 100 |  |  | V |
| $\mathrm{I}_{\mathrm{DSS}}$ | Zero gate voltage <br> drain current $\left(\mathrm{V}_{\mathrm{GS}}=0\right)$ | $\mathrm{V}_{\mathrm{DS}}=$ Max rating <br> $\mathrm{V}_{\mathrm{DS}}=\mathrm{Max}$ rating, <br> $\mathrm{T}_{\mathrm{C}}=125^{\circ} \mathrm{C}$ |  |  | 1 |  |
| 10 | $\mu \mathrm{~A}$ |  |  |  |  |  |
| $\mu \mathrm{~A}$ |  |  |  |  |  |  |$|$

Table 4. Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{g}_{\mathrm{fs}}{ }^{(1)}$ | Forward transconductance | $\mathrm{V}_{\mathrm{DS}}=15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=12.5 \mathrm{~A}$ |  | 24 |  | S |
| $\mathrm{C}_{\text {iss }}$ <br> Coss <br> $\mathrm{C}_{\text {rss }}$ | Input capacitance Output capacitance Reverse transfer capacitance | $\begin{aligned} & \mathrm{V}_{\mathrm{DS}}=25 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}, \\ & \mathrm{~V}_{\mathrm{GS}}=0 \end{aligned}$ |  | $\begin{gathered} 1710 \\ 250 \\ 110 \end{gathered}$ |  | pF <br> pF <br> pF |
| $\begin{gathered} \mathrm{t}_{\mathrm{d}(\mathrm{on})} \\ \mathrm{t}_{\mathrm{r}} \\ \mathrm{t}_{\mathrm{d}(\mathrm{off})} \\ \mathrm{t}_{\mathrm{f}} \end{gathered}$ | Turn-on delay time Rise time Turn-off delay time Fall time | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=50 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=12.5 \mathrm{~A} \\ & \mathrm{R}_{\mathrm{G}}=4.7 \Omega \mathrm{~V}_{\mathrm{GS}}=5 \mathrm{~V} \\ & \text { (see Figure 13) } \end{aligned}$ |  | $\begin{aligned} & 20 \\ & 40 \\ & 58 \\ & 20 \end{aligned}$ |  | ns <br> ns <br> ns <br> ns |
| $\begin{aligned} & \mathrm{Q}_{\mathrm{g}} \\ & \mathrm{Q}_{\mathrm{gs}} \\ & \mathrm{Q}_{\mathrm{gd}} \end{aligned}$ | Total gate charge Gate-source charge Gate-drain charge | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=80 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=25 \mathrm{~A}, \\ & \mathrm{~V}_{\mathrm{GS}}=5 \mathrm{~V}, \mathrm{R}_{\mathrm{G}}=4.7 \Omega \\ & \text { (see Figure 14) } \end{aligned}$ |  | $\begin{aligned} & 38 \\ & 8.5 \\ & 21 \end{aligned}$ | 52 | $\begin{aligned} & \mathrm{nC} \\ & \mathrm{nC} \\ & \mathrm{nC} \end{aligned}$ |

1. Pulsed: Pulse duration $=300 \mu \mathrm{~s}$, duty cycle $1.5 \%$.

Table 5. Source drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\stackrel{I_{S D}}{\mathrm{I}_{\mathrm{SDM}}{ }^{(1)}}$ | Source-drain current Source-drain current (pulsed) |  |  |  | $\begin{gathered} 25 \\ 100 \end{gathered}$ | $\begin{aligned} & \text { A } \\ & \text { A } \end{aligned}$ |
| $\mathrm{V}_{\mathrm{SD}}{ }^{(2)}$ | Forward on voltage | $\mathrm{I}_{\mathrm{SD}}=25 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0$ |  |  | 1.5 | V |
| $\mathrm{t}_{\mathrm{rr}}$ $\mathrm{Q}_{\mathrm{rr}}$ <br> $I_{\text {RRM }}$ | Reverse recovery time Reverse recovery charge Reverse recovery current | $\begin{aligned} & \mathrm{I}_{\mathrm{SD}}=25 \mathrm{~A}, \mathrm{di} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}, \\ & \mathrm{~V}_{\mathrm{DD}}=50 \mathrm{~V}, \mathrm{~T}_{\mathrm{j}}=150^{\circ} \mathrm{C} \\ & \text { (see Figure 15) } \end{aligned}$ |  | $\begin{gathered} \hline 88 \\ 317 \\ 7.2 \\ \hline \end{gathered}$ |  | $\begin{gathered} \mathrm{ns} \\ \mathrm{nC} \\ \mathrm{~A} \end{gathered}$ |

1. Pulse width limited by safe operating area.
2. Pulsed: Pulse duration $=300 \mu \mathrm{~s}$, duty cycle $1.5 \%$

### 2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance


Figure 4. Transfer characteristics

Figure 3. Output characterisics


Figure 5. Transconductance
Figure 6. Static drain-source on resistance


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations


Figure 9. Normalized gate threshold voltage vs temperature


Figure 11. Source-drain diode forward characteristics


Figure 10. Normalized on resistance vs temperature


Figure 12. Normalized breakdown voltage vs temperature


## 3 Test circuit

Figure 13. Switching times test circuit for resistive load


Figure 14. Gate charge test circuit

Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped Inductive load test circuit


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

DPAK MECHANICAL DATA

| DIM. | mm . |  |  | inch |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | MIN. | TYP | MAX. | MIN. | TYP. | MAX. |
| A | 2.2 |  | 2.4 | 0.086 |  | 0.094 |
| A1 | 0.9 |  | 1.1 | 0.035 |  | 0.043 |
| A2 | 0.03 |  | 0.23 | 0.001 |  | 0.009 |
| B | 0.64 |  | 0.9 | 0.025 |  | 0.035 |
| b4 | 5.2 |  | 5.4 | 0.204 |  | 0.212 |
| C | 0.45 |  | 0.6 | 0.017 |  | 0.023 |
| C2 | 0.48 |  | 0.6 | 0.019 |  | 0.023 |
| D | 6 |  | 6.2 | 0.236 |  | 0.244 |
| D1 |  | 5.1 |  |  | 0.200 |  |
| E | 6.4 |  | 6.6 | 0.252 |  | 0.260 |
| E1 |  | 4.7 |  |  | 0.185 |  |
| e |  | 2.28 |  |  | 0.090 |  |
| e1 | 4.4 |  | 4.6 | 0.173 |  | 0.181 |
| H | 9.35 |  | 10.1 | 0.368 |  | 0.397 |
| L | 1 |  |  | 0.039 |  |  |
| (L1) |  | 2.8 |  |  | 0.110 |  |
| L2 |  | 0.8 |  |  | 0.031 |  |
| L4 | 0.6 |  | 1 | 0.023 |  | 0.039 |
| R |  | 0.2 |  |  | 0.008 |  |
| V2 | $0^{\circ}$ |  | $8^{\circ}$ | $0^{\circ}$ |  | $8^{\circ}$ |



## 5 Packing mechanical data

## DPAK FOOTPRINT



TAPE AND REEL SHIPMENT


TAPE MECHANICAL DATA

| DIM. | mm |  | inch |  |
| :---: | :---: | :---: | :---: | :---: |
|  | MIN. | MAX. | MIN. | MAX. |
| A0 | 6.8 | 7 | 0.267 | 0.275 |
| B0 | 10.4 | 10.6 | 0.409 | 0.417 |
| B1 |  | 12.1 |  | 0.476 |
| D | 1.5 | 1.6 | 0.059 | 0.063 |
| D1 | 1.5 |  | 0.059 |  |
| E | 1.65 | 1.85 | 0.065 | 0.073 |
| F | 7.4 | 7.6 | 0.291 | 0.299 |
| K0 | 2.55 | 2.75 | 0.100 | 0.108 |
| P0 | 3.9 | 4.1 | 0.153 | 0.161 |
| P1 | 7.9 | 8.1 | 0.311 | 0.319 |
| P2 | 1.9 | 2.1 | 0.075 | 0.082 |
| R | 40 |  | 1.574 |  |
| W | 15.7 | 16.3 | 0.618 | 0.641 |



## 6 Revision history

Table 6. Revision history

| Date | Revision | Changes |
| :---: | :---: | :--- |
| 21-Jun-2004 | 1 | Preliminary version |
| 03-Jun-2006 | 2 | New template, no content change |

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